


<b>Search Notes</b> 	<b>Application/Control No.</b> 10700908	<b>Applicant(s)/Patent Under Reexamination</b> RASPL, STEFAN
	<b>Examiner</b> SUSAN Y CHEN	<b>Art Unit</b> 2161

SEARCHED			
Class	Subclass	Date	Examiner
707	1, 3, 6, 7, 101, 102	9/12/08	tyc
702	179, 190	9/12/08	tyc
707	all	03/24/09	tyc
717	all	03/24/09	tyc
709	all	03/24/09	tyc

SEARCH NOTES		
Search Notes	Date	Examiner
Palm inventor search	03/24/09	tyc
NPL -Google, IEEE, ACM	03/24/09	tyc

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
707	all	03/24/09	tyc

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